Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/747,644	DEMIR ET AL.	
Examiner	Art Unit	
Eva Yi Zheng	2611	

SEARCHED					
Class	Subclass	Date	Examiner		
. 375	322	4/24/2007	E.Z		
375	316	4/24/2007	E.Z		
375	324	4/24/2007	E.Z		
455	209	4/24/2007	E.Z		
455	130	4/24/2007	E.Z		
455	249.1	4/24/2007	E.Z		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	316	4/24/2007	E.Z	
375	324	4/24/2007	E.Z	
455	209	4/24/2007	E.Z	
interference search (see attachment)		4/24/2007	E.Z	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
updated EAST search	4/24/2007	E.Z		
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